

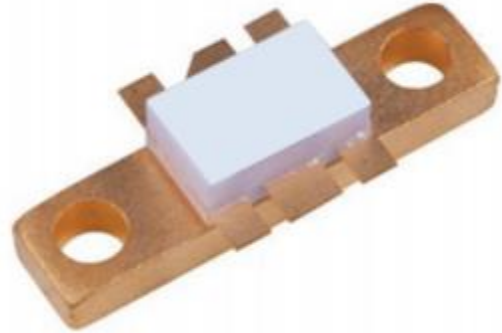
# RF Silicon Mosfet

## 2.5W 500MHz 28V Single-Ended

### D2014UK

#### Features:

- Simplified Amplifier Design
- Suitable for Broad Band Applications
- Low  $C_{RSS}$
- Simple Bias Circuits
- Low Noise
- High Gain – 13dB Minimum
- RoHS Compliant



#### Description:

Single-Ended RF Silicon Mosfet. 2.5W at 500MHz, 28V

#### Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

$P_D$	Power Dissipation	17.5W
$BV_{DSS}$	Drain – Source Breakdown Voltage	65V
$BV_{GSS}$	Gate – Source Breakdown Voltage	$\pm 20\text{V}$
$I_D(\text{sat})$	Drain Current	1A
$T_{stg}$	Storage Temperature	-65 to +150°C
$T_j$	Maximum Operating Junction Temperature	200°C

#### Thermal Properties

SYMBOL	PARAMETER	MAX	UNITS
$R_{\theta JC}$	Thermal Resistance, Junction to Case	10.0	°C/W

#### General Note

TT Electronics reserves the right to make changes in product specification without notice or liability. All information is subject to TT Electronics' own data and is considered accurate at time of going to print.

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### Electrical Specifications

#### Electrical Characteristics (T<sub>A</sub> = 25° C unless otherwise noted)

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 10mA	65			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 28V, V <sub>GS</sub> = 0V			1	mA
I <sub>GSS</sub>	Gate leakage Current	V <sub>GS</sub> = 20V, V <sub>DS</sub> = 0V			1	μA
V <sub>GS(th)</sub>	Gate Threshold Voltage	I <sub>D</sub> = 10mA, V <sub>DS</sub> = V <sub>GS</sub>	1		7	V
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> = 10V, I <sub>D</sub> = 0.2A	0.18			S
G <sub>PS</sub>	Common Source Power Gain	P <sub>O</sub> = 2.5W	13			dB
η	Drain Efficiency	V <sub>DS</sub> = 28V, I <sub>DQ</sub> = 0.1A	40			%
VSWR <sup>(1)</sup>	Load Mismatch Tolerance	f = 500MHz	20:1			-
C <sub>iss</sub> <sup>(1)</sup>	Input Capacitance	V <sub>DS</sub> = 28V, V <sub>GS</sub> = -5V f = 1MHz			12	pF
C <sub>oss</sub> <sup>(1)</sup>	Output Capacitance	V <sub>DS</sub> = 28V, V <sub>GS</sub> = 0V f = 1MHz			6	pF
C <sub>rss</sub> <sup>(1)</sup>	Reverse Transfer Capacitance	V <sub>DS</sub> = 28V, V <sub>GS</sub> = 0V f = 1MHz			0.5	pF

#### Notes:

- (1) By design only, not a production test

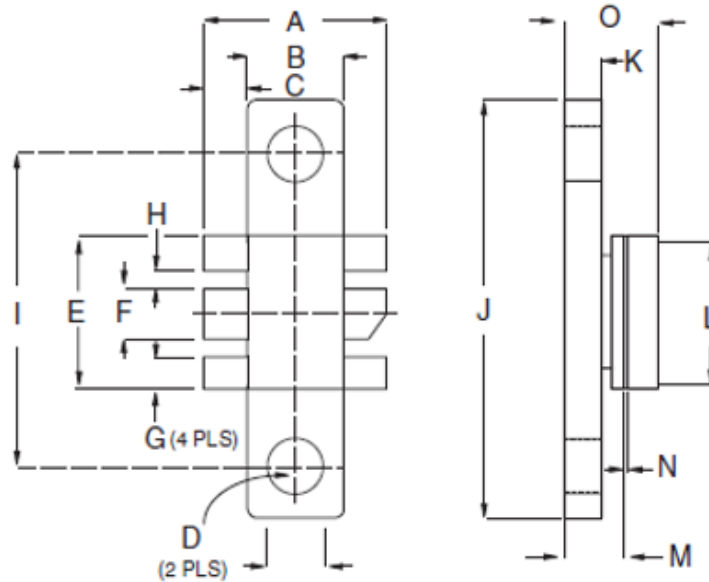
#### HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and metal flange is beryllium oxide. Beryllium oxide dust is highly toxic and care must be taken during handling and mounting to avoid damage to this area.

**THESE DEVICES MUST NEVER BE THROWN AWAY WITH GENERAL INDUSTRIAL OR DOMESTIC WASTE**

### Packaging

#### Mechanical Data



#### SOT171

##### Top View

Pin 1 - Source      Pad 2 - Source  
 Pin 3 - Gate      Pin 4 - Drain  
 Pin 5 - Source      Pin 6 - Source

DIM	mm	Tol.	Inches	Tol.
A	10.92	0.38	0.430	0.015
B	5.84	0.13	0.230	0.005
C	2.54	0.13	0.100	0.005
D	3.30 dia	1.27	0.130 dia	0.050
E	9.14	0.13	0.360	0.005
F	3.05	0.13	0.120	0.005
G	2.01	0.13	0.079	0.005
H	1.07	0.13	0.042	0.005
I	18.42	0.13	0.725	0.005
J	24.77	0.13	0.975	0.005
K	2.79	0.13	0.110	0.005
L	9.14	0.13	0.360	0.005
M	4.22	0.25	0.166	0.010
N	0.13	0.05	0.005	0.002
O	7.37	MAX	0.290	MAX

### Revision Control

ISSUE	CHANGE DESCRIPTION	APPROVAL	DATE
1	First issue	P.Smith	04-09-2001
2	Corrected test frequency from 1GHz to 500MHz	P.Smith	23-01-2003
3	Corrected dimension tolerances	P.Smith	25-06-2020